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A methodological inter-comparison study on the detection of surface contaminant sodium dodecyl sulfate applying ambient- and vacuum-based techniques

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A methodological inter-comparison study on the detection of surface contaminant sodium dodecyl sulfate applying ambient- and vacuum-based techniques

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Keywords:	sodium dodecyl sulfate, ambient mass spectrometry, Raman spectroscopy, Fourier-Transform infrared spectroscopy, reference-free X-ray fluorescence spectroscopy, biomedical devices

Cover letter

Andrea Mario Giovannozzi

A. M. Giovannozzi
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Torino, 01-August-18

Dear Editor, dear Referees,

Please find enclosed the manuscript entitled “*A methodological inter-comparison study on the detection of surface contaminant sodium dodecyl sulfate applying ambient- and vacuum-based techniques*” that I would like to present for your consideration for publication in *Analytical and Bioanalytical Chemistry*.

Our multi-technique approach focusses on the analytical research field of biomedical devices. Biomedical devices are complex products requiring numerous assembly steps along the industrial process chain carrying the potential of surface contamination. Cleanliness has to be analytically assessed with respect to ensuring safety and efficacy. Although several analytical techniques are routinely employed for process control, a reliable analysis chain with traceability is needed. This calls for multi-modal analytical methodologies that are cascaded in a sensible way to immediately identify and localize possible contamination, both qualitatively and quantitatively.

In this inter-comparative approach, we produced and characterized SDS model films that were deliberately deposited onto different flat in-/organic substrates, serving as potentially implementable reference materials for calibration (‘model samples’) of ambient techniques such as Ambient Mass Spectrometry (AMS), Infrared and Raman spectroscopy.

Moreover, ‘real samples’, i.e. biomedical devices with a convex geometry, such as a hip liner, were deliberately contaminated with SDS in order to emulate a contaminated sample emerging from an industrial process chain.

We demonstrate that non-invasive and complementary Raman and IR spectroscopy offer *a priori* chemical identification with integrated chemical imaging tools for qualitatively and quickly following the contaminant distribution on the μm scale, even on hip liner devices. Both readout techniques may be slotted in ahead all other remaining techniques discussed in our inter-comparison approach, followed by the traceable reference-free XRF analysis.

Cover letter

Andrea Mario Giovannozzi

AMS capable to provide mass spectroscopic fingerprints for fast qualitative identification of surface contaminations we consider to be used at the end of the traceability chain, as it is moderately destructive technique relying on the removal of material from the sample surface.

To absolutely determine the mass deposition of SDS, vacuum-based reference-free XRF was implemented. Since ambient techniques necessitate reference materials / standards for quantitative analyses, SI-traceable XRF was capable to quantify the amount of organic SDS contaminant on in-/organic substrates.

Summarizing all, our approach demonstrates that the increase of information depth provided by combining all techniques has the potential to enable even on-line characterization and chemical speciation within the process chain in the biomedical device industry

We believe in the novelty of our multi-modal approach undertaken in this manuscript as an easily implementable high-throughput readout platform of high relevance in the field of biomedical device industries. We think that our findings could appeal to a broad, multi-disciplinary readership of *Analytical and Bioanalytical Chemistry*.

Yours Sincerely,

A. M. Giovannozzi and on behalf of all co-authors

1 A methodological inter-comparison study on the detection
2 of surface contaminant sodium dodecyl sulfate applying
3 ambient- and vacuum-based techniques

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26 *Electronic Supplementary Material (ESM) available.*

1
2
3 28 **Abstract**

4
5 29 Biomedical devices are complex products requiring numerous assembly steps along the
6
7 30 industrial process chain, which can carry the potential of surface contamination. Cleanliness
8
9 31 has to be analytically assessed with respect to ensuring safety and efficacy. Although several
10
11 32 analytical techniques are routinely employed for such evaluation, a reliable analysis chain that
12
13 33 guarantees metrological traceability and quantification capability is desirable. This calls for
14
15 34 analytical tools that are cascaded in a sensible way to immediately identify and localize
16
17 35 possible contamination, both qualitatively and quantitatively.

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19
20 36 In this systematic inter-comparative approach, we produced and characterized sodium dodecyl
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22 37 sulfate (SDS) films mimicking contamination on inorganic and organic substrates, with
23
24 38 potential use as reference materials for ambient techniques, i.e., Ambient mass spectrometry
25
26 39 (AMS), Infrared and Raman spectroscopy, to reliably determine amounts of contamination.
27
28 40 Non-invasive and complementary vibrational spectroscopy techniques offer *a priori* chemical
29
30 41 identification with integrated chemical imaging tools to follow the contaminant distribution,
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32 42 even on devices with complex geometry. AMS also provides fingerprint outputs for a fast
33
34 43 qualitative identification of surface contaminations to be used at the end of the traceability
35
36 44 chain due to its ablative effect on the sample. To absolutely determine the mass of SDS, the
37
38 45 vacuum-based reference-free technique X-ray fluorescence was employed for calibration.
39
40 46 Convex hip liners were deliberately contaminated with SDS to emulate real biomedical
41
42 47 devices with an industrially relevant substance. Implementation of the aforementioned
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44 48 analytical techniques is discussed with respect to combining multimodal technical setups to
45
46 49 decrease uncertainties that may arise if a single technique approach is adopted.
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1
2
3 52 **Keywords**

4 53 *sodium dodecyl sulfate, ambient mass spectrometry, Raman spectroscopy, Fourier-Transform*
5
6
7 54 *infrared spectroscopy, reference-free X-ray fluorescence spectroscopy, biomedical devices*

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11 56

12
13 57 **Introduction**

14
15 58 Biomedical devices such as implantable joint prostheses, orthopedic pins, plates, nails and
16
17 59 cardiovascular stents are complex products requiring significant manufacturing and assembly
18
19 60 steps. This may give rise to surface contamination from process fluids, lubricants, cleaning
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21 61 fluids or other residues, which has to be removed and rinsed away prior to final packaging of
22
23 62 the product. Many materials such as detergents, surfactants and buffers are often employed for
24
25 63 cleaning, but their intensive use has to be carefully evaluated in order to avoid the
26
27 64 introduction of new residues or their solubilization and migration from one location to
28
29 65 another. Moreover, the effectiveness of the cleaning process has to be considered with respect
30
31 66 to the potential damage of the device since these chemicals are often used in combination with
32
33 67 mechanical and thermal treatments. Therefore, the entire approach for assessing the
34
35 68 cleanliness of a medical device has to be analytically evaluated for ensuring both safety and
36
37 69 efficacy of the product.

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41 70 Manufacturers strive for the highest quality final products whilst also desiring improvements
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43 71 in manufacturing efficiency by using cost-effective, industrially practical high-throughput
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45 72 analysis technologies. Various analytical methods are used to evaluate the cleanliness of
46
47 73 biomedical devices such as Gas chromatography–Mass Spectrometry (GC-MS), High
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49 74 pressure Liquid chromatography–Mass Spectrometry (HPLC-MS), Inductively coupled
50
51 75 plasma-Mass Spectrometry (ICP-MS), X-ray diffraction (XRD) and Gravimetric analysis

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3 76 [1,2], which usually guarantee high sensitivity in the quantification of the contaminants upon
4
5 77 extraction and separation steps. However, they cannot provide information about the spatial
6
7 78 distribution of any contaminants, whose knowledge is fundamental to provide clues as to the
8
9 79 how/where in the manufacturing and cleaning history the contamination has occurred and how
10
11 80 different surface finishes or materials may be more or less susceptible to contamination.

12
13 81 High-end surface analytical methods such as X-ray photoelectron spectroscopy (XPS) or
14
15 82 Time-of-Flight Secondary Ion Mass Spectrometry (ToF-SIMS) are ideally suited
16
17 83 spectroscopic techniques that can provide both high sensitivity and spatially resolved
18
19 84 information with high surface specificity. However, these methods are both time-consuming,
20
21 85 mainly owing to the need for high vacuum and for appropriate (potentially time consuming)
22
23 86 sample preparation and significant expense. They are also generally incapable of handling the
24
25 87 complex geometry of complete medical devices. Hence, there is a need for analytical methods
26
27 88 that provide trace-level sensitivity and surface selectivity and specificity, whilst providing
28
29 89 spatially resolved information, preferably with the option to deploy such methods at point of
30
31 90 manufacture or distribution. The latter requirement implies a high degree of convenience and
32
33 91 rapid throughput practicality. Emerging ambient techniques, either based on vibrational
34
35 92 spectroscopy or mass spectrometry, for instance, are far better suited to the manufacturing
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37 93 environment, but currently these techniques lack reproducibility and traceability, as they rely
38
39 94 on standards / reference materials needed for the characterization of advanced biomaterials
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41 95 and complex sample presentation requirements to enable quantitation.

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46 96 The aim of our work is to develop the foundation metrology needed to provide robust,
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48 97 reproducible, surface sensitive and selective analysis of biomedical device materials by using
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50 98 Ambient Mass Spectrometry (AMS), Fourier-Transform infrared (FTIR) microscopy and
51
52 99 Micro-Raman Spectroscopy. AMS-based techniques such as Desorption Electrospray
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3 100 Ionization (DESI), Plasma Assisted Desorption Ionization (PADI) and Liquid Extraction
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5 101 Surface Analysis (LESA) already demonstrated their applications as indispensable tools for
6
7 102 polymer science [3], pharmaceutical science [4], and biosamples (biofluids, tissues, cells)
8
9 103 characterization combined with imaging tools [5,6]. AMS has been, as far as we are aware,
10
11 104 rarely used, in relation to surface contaminants analysis on real biomedical devices and
12
13 105 specifically for characterization of typical surface contaminants [7]. Similarly to vibrational
14
15 106 spectroscopies, AMS can provide rich chemical information, highly specific for polymers or
16
17 107 even impurities on mixed polymeric materials, enabling quantitative structural analytics.
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19 108 Micro-FTIR and micro-Raman spectroscopy also offer great promise for meeting the medical
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21 109 device industry needs for on-line surface quality assessment and process control [8]. In
22
23 110 addition to providing detailed and specific chemical information by FTIR/Raman-based
24
25 111 molecular fingerprints, both techniques enable non-destructive readout, and can be combined
26
27 112 with a micro-spectroscopic setup. Such chemical imaging can provide insights into
28
29 113 contaminant distribution on devices and by providing semi-quantitative spatially resolved
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31 114 information.
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34
35 115 Herein we present a systematic study on a commonly encountered small molecule detergent,
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37 116 namely sodium dodecyl sulphate (SDS), that is widely manufactured and used in household
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39 117 detergents, personal care products, emulsification, lubrication, catalysis, plastics industry, and
40
41 118 electroplating [9–11]. A variety of surfactants, including the anionic type employed in this
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43 119 study, show relatively low biodegradability and a high tendency to be absorbed by natural
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45 120 materials [12]. Consequently, they are harmful to humans and carrying bacteria and pollutants
46
47 121 over quite a long distance [13]. Several approaches were developed to detect SDS, mostly
48
49 122 based on spectrophotometric, amperometric, fluorescence, chromatographic and biosensing
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51 123 analysis [14–19]. However, these techniques have low specificity, as they cannot distinguish
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124 similar but different surfactants. They can be applied restrictively, as they usually enable the
125 analysis of liquids, thus hindering their use for *in situ* detection.

126 This calls for new strategies for setting up robust and combined analytical methods for
127 sensitive, selective, and early-stage characterization of surfactants within the industrial
128 processing chains.

129 We investigated the SDS physicochemical distribution and amount on different sample
130 substrates, based on inorganic (silicon: Si, and stainless steel: SST) and organic materials
131 (high-density polyethylene: HDPE), utilizing ambient techniques such as AMS, FTIR, and
132 Raman micro-spectroscopy, and vacuum-based techniques such as X-ray fluorescence
133 spectroscopy (XRF). While ambient techniques necessitate reference materials / standards for
134 quantitative analyses, XRF analysis is capable of absolute quantitative determination of the
135 content of in-/organic components, enabling a reference-free SI-traceable quantification of
136 the contaminant on the surface [7]. This inter-comparison study provides spatially resolved
137 information related to the specificity and sensitivity of SDS detection, with regard to the use
138 of both ambient and vacuum techniques.

139 Moreover, real biomedical devices with a complex geometry such as a hip liner were
140 deliberately contaminated with SDS in order to emulate a real contaminated sample system
141 from an industrial processing chain, and were analyzed by means of all analytical techniques
142 to test their efficiency of detection.

143

144 **Materials and Methods**

145 ***Chemical reagents***

146 Sodium dodecyl sulfate (Sigma Aldrich, MW: 288.38 g/mol, > 99.0 % purity) and formic acid
147 (99%, Sigma-Aldrich) were purchased from Sigma Aldrich. The solvents used were deionized

1
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3 148 water ($>18 \text{ M}\Omega \text{ cm}^{-1}$), acetonitrile (ACN) (99.99 Sigma, UK), methanol (MeOH), ethanol
4
5 149 (EtOH) and propan-2-ol (IPA) (FisherScientific, UK).
6
7 150 SDS was deposited onto substrates of Silicon (Si), Stainless Steel (SST) and High Density
8
9 151 Polyethylene (HDPE). Stainless Steel was supplied by Goodfellow AISI 316
10
11 152 (Fe/Cr18/Ni10/Mo3) Foil, 0.914 mm thick annealed. Upon arrival of the SST, one face was
12
13 153 polished to a high shine. HDPE wafers were supplied from Sigma Aldrich and modified using
14
15 154 a heat press to ensure a flat surface.
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18 155

19 20 156 ***Preparation of SDS model contaminant films on Si, SST and HDPE substrates***

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22 157 For the preparation of the model systems used in the comparative study, SDS was deposited
23
24 158 onto clean Si, SST and HDPE substrates with a TM sprayer (HTX Technologies). The SDS
25
26 159 spraying condition was as follows: flow rate 0.125 mL/min, gas pressure 10 psi, spraying
27
28 160 temperature 80 °C, velocity 1333 mm/min, number of passages 8, track spacing 3 mm with an
29
30 161 offset spacing of 1.5 mm. SDS was dissolved in 80% methanol solution at 0.25 mg/mL
31
32 162 concentration and spray-coated onto the sample substrates to a surface concentration of 5×10^{-6}
33
34 163 g/cm^2 which, with an assumed density of 1.01 g/cm^3 for SDS, equates to a layer thickness of
35
36 164 approximately 50 nm. Solution concentrations of 0.25 mg/mL were chosen as being close to
37
38 165 the critical micelle concentration (CMC) of SDS, which ranges between 0.17 and 0.23 % w/v
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40 166 (in water/buffer). SDS has been demonstrated to inhibit mammalian cell culture at
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42 167 concentrations close to its CMC [20].
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47 48 169 ***Contamination of hip liners with SDS as 'real samples'***

49
50 170 Hip liners from Smith & Nephew were deliberately contaminated with SDS in order to
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52 171 emulate real biomedical devices with a low enough level of contamination to be analytically
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3 172 challenging yet illustrative of whether such low level contamination in an industrial
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5 173 processing chain may be detectable on a real product surface. The hip liner consisting of ultra-
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7 174 high-molecular-weight polyethylene (UHMWPE) was contaminated with SDS using an
8
9 175 airbrush. A solution of 0.25 mg/mL was sprayed as homogeneously as possible to produce a
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11 176 film thickness of ~50 nm.

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15 178 ***Vacuum-based techniques***

16
17 179 *XRF analysis*

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20 180 For the quantitative analysis of SDS, the Plane Grating Monochromator (PGM) beamline for
21
22 181 undulator radiation at the PTB laboratory at BESSY II was employed [21–23]. The beamline
23
24 182 PGM-U49 provides monochromatized undulator radiation in the energy range from 78 eV to
25
26 183 1870 eV with high spectral purity and well-known flux (or radiant power) [21,22]. Attached
27
28 184 to this beamline, an ultra-high vacuum chamber has been used, equipped with a 9 axis
29
30 185 manipulator, enabling a very precise adjustment of the samples, and in particular, extremely
31
32 186 precise control of incidence angle [24]. This UHV chamber and the sample holder is placed in
33
34 187 the focal plane of the PGM beamline, which has a vertical size of about 170 μm . The excited
35
36 188 fluorescence radiation is detected by a radiometrically calibrated energy-dispersive Silicon
37
38 189 drift detector (SDD) [22]. Calibrated means in that sense, that the efficiency and the detector
39
40 190 response functions are well-known. In addition, the solid angle of detection can be determined
41
42 191 as described in ref. [25]. For a more precise determination of the solid angle of detection, a
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44 192 calibrated diaphragm was used. In case of the coated hip liners, it has been employed due to
45
46 193 the fact that the incidence angle is not well-defined because of the irregular curved surface of
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48 194 the hip liner, having a significant impact on quantification. For the model systems, this was
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50 195 not the case, so the determination was carried out as described in ref. [25]. The radiant power
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3 196 or flux from the beamline is detected by calibrated photo diodes with known response for
4
5 197 photon energy. All these calibrated instruments allow for a reference-free quantification of the
6
7 198 mass per unit area and the elemental composition by employing a fundamental parameter
8
9 199 approach [25].
10

200

201 *Reference-free XRF*

15 202 The quantitative analysis of the absolute mass per unit area and the elemental composition
16
17 203 was carried out by using a fundamental parameter approach as introduced by Beckhoff *et al.*
18
19 204 [25]. Here, all experimental and atomic fundamental parameters have to be well-known. For
20
21 205 this purpose, the calibrated instrumentation described in the ESM is used.
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23

24 206 For the reference-free quantification of SDS, X-ray fluorescence analysis under grazing
25
26 207 incidence conditions and in conventional 45° / 45° geometry was carried out. The model
27
28 208 systems were measured at an incidence angle of about 45° and at a photon energy of 1622 eV.
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30 209 Here, the Na K α , O K α , and C K α fluorescence line intensities were used for the
31
32 210 quantification. The hip liners were analyzed by using a photon energy of about 1487 eV to
33
34 211 excite all the relevant elements excluding sulfur. The incidence angle was approximately 10°.
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213 *Ambient Techniques*214 *Ambient Mass Spectrometry – PADI, DESI and LESA MS*

43 215 Different atmospheric pressure desorption/ionization sources were used: a plasma assisted
44
45 216 desorption ionization (PADI) source [26], a Prosolia 2D automated Omni Spray Ion Source
46
47 217 (Indianapolis, USA) for desorption electrospray ionization (DESI) source [27] and an Advion
48
49 218 Biosciences TriVersaNanoMatesource (Harlow, UK) for liquid extraction surface analysis
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51 219 (LESA) measurements [28]. These were coupled to a Thermo Scientific LTQ-OrbitrapVelos
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3 220 mass spectrometer, and experiments were performed using the high mass resolution setting of
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5 221 100,000 at m/z 400.
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7 222 DESI was set up as optimized; briefly, a solvent flow rate of 2 $\mu\text{L}/\text{min}$ was used. The voltage
8
9 223 was 5 kV and nitrogen gas was supplied at 100 psi. The electrospray was freshly prepared,
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11 224 either using 50% methanol or 90% acetonitrile with 0.01% formic acid in deionized water.
12
13 225 The PADI instrument was built in-house at the National Physical Laboratory, UK and the set
14
15 226 up was optimized as described in ref. [29]. A plasma power of 15 W and helium flow rate of
16
17 227 800 ml/min was used. The LESA technique parameters used in this investigation were as
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19 228 follows: solvent volume 3 μL , solvent depth 1 μL , dispense 2 μL , delay 2 s, aspirate 1.8 μL ,
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21 229 dispensing height -7.0 mm, aspiration height -7.0 mm, delivery time 1 min, gass pressure 0.3
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23 230 psi, and voltage 1400 V.
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28 232 *Synchrotron radiation (SR)-based FTIR spectroscopy*

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30 233 FTIR spectroscopic measurements were performed at the IR beamline ‘IRMA’ of the electron
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32 234 storage ring Metrology Light Source (MLS) of PTB which is optimized for the wavelength
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34 235 range between 1 μm and 20 μm [30,31]. Experiments were performed with a Vertex-80v
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36 236 FTIR spectrometer coupled to an IR microscope Hyperion 3000 (Bruker Optics GmbH,
37
38 237 Germany) equipped with a 128^2 pixels FPA detector (Focal Plane Array, pixel size $\sim 3 \mu\text{m}$ at
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40 238 $15\times$ magnification) and Mercury Cadmium Telluride (MCT) detector. For point-wise FTIR
41
42 239 spectroscopical measurements, the SR source ($\sigma_x=670 \mu\text{m}$, $\sigma_y=183 \mu\text{m}$, beam current ~ 170
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44 240 mA) was focused through an ATR (attenuated total reflection) objective of 15 fold
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46 241 magnification onto the model sample systems; here SDS-coated Si, SST and HDPE substrates
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48 242 were investigated. Additionally, the HDPE-based Hip Liners with/without SDS contamination
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50 243 as “real sample systems” were analyzed by FTIR-ATR spectroscopy. MIR-spectra from 3900
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3 244 cm^{-1} to 900 cm^{-1} were acquired with the MCT detector system in reflection mode by co-
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5 245 adding 128 scans at 4 cm^{-1} resolution for the data acquisition. Background scans were
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7 246 collected before each sample measurement from a region free of sample and a ratio was taken
8
9 247 against the sample spectrum.

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11 248

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13 249 *Raman micro-spectroscopic analysis*

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15 250 Raman spectra were recorded using a dispersive Thermo Scientific DXR Raman spectrometer
16
17 251 equipped with a microscope, an excitation laser source at 455 nm or 532 nm, a motorized
18
19 252 stage sample holder (step size: $1 \mu\text{m}$), and a charge-coupled device (CCD) detector. Spectra of
20
21 253 SDS model systems on Si, SST and HDPE were collected using a $100\times$ microscope objective
22
23 254 (laser spot diameter: $0.6 \mu\text{m}$) with a laser power from 5 mW to 10 mW and a spectral range
24
25 255 from 3500 cm^{-1} to 50 cm^{-1} with a grating resolution of 5 cm^{-1} . The acquisition time was of 100
26
27 256 scans with 5 s exposure time. Same parameters were used for the analysis of the UHMWPE -
28
29 257 based hip liners contaminated with SDS.

30
31
32 258 Micro-Raman Imaging Spectroscopy of SDS model systems was conducted with a DXR™ xi
33
34 259 Raman Imaging Microscope (Thermo Scientific) using a laser wavelength at 455 nm, a laser
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36 260 power of 5 mW, a $50\times$ microscope objective and a motorized stage with a $2 \mu\text{m}$ step size.
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38 261 Spectra were collected in the 3500 cm^{-1} - 50 cm^{-1} spectral region with a grating resolution of 5
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40 262 cm^{-1} , an exposure time of 0.02 s and 100 scans in total. Raman chemical images were
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42 263 represented using a false color scale, from blue (low signal) to red (high signal), related to the
43
44 264 intensity of the symmetric stretching of the SO_4 at 1083 cm^{-1} .

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3 2684 269 **Results & Discussion**5
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7 270 *XRF analysis on SDS model contaminant layers*

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9 271 In order to develop and evaluate consistent SDS model layers systems that should function as
10
11 272 potential reference/calibration samples, investigations on homogeneous integrity and
12
13 273 contamination thicknesses of the respective sprayed SDS layers were firstly performed by
14
15 274 XRF. Specifically, SDS contaminants' layer thicknesses were absolutely determined by non-
16
17 275 destructive reference-free XRF and their distribution on each type of substrate was evaluated
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19 276 on the basis of the XRF signal response obtained at different sample positions.

20
21 277 The model systems were measured at an incidence angle of about 45° at a photon energy 1622
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23 278 eV (Table 1). Here, Na K α , O K α , and C K α fluorescence line intensities were used for the
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25 279 quantification.

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27
28 280 **Fig.1**

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30 281
31
32 282 In Fig. 1 typical XRF spectra are shown for different types of substrate samples which are
33
34 283 characterized by the fluorescence lines of the SDS (C, O, and Na) and the respective substrate
35
36 284 material, as Cr, Fe, and Ni for the stainless steel substrate, and Si for the wafer. For the
37
38 285 quantification of SDS, the intensity of the fluorescence lines of sodium was analyzed. The
39
40 286 elements carbon and oxygen were only used for comparison, because the substrate material
41
42 287 contains significant fractions of them. Assuming the Na mass deposition arises only from the
43
44 288 SDS and the stoichiometry of SDS is known, the mass deposition of all other involved
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46 289 elements was determined.

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Table 1

291 If knowledge of the density is available, the mass deposition can be converted into thickness.

292 Here, the thickness is determined assuming the bulk density of SDS. The thickness of SDS is

293 about 44 ± 6 nm for the SST substrate, 41 ± 6 nm for HDPE and 37 ± 6 nm for the Si wafer.

294 From the deposition process of the SDS layer, the nominal thickness was assumed to be about

295 50 nm. The experimentally determined thicknesses are in the same order of magnitude, but

296 slightly thinner, in particular for the deposition on Si.

297 Considering the mass deposition of oxygen, the determined content includes additional

298 contributions from the substrates excluding the HDPE, which has only minor surface

299 contamination. The Si substrate shows the smallest amount of adventitious C contaminations.

300 Further, this methodology turned out to be very suitable for extracting information of

301 elemental composition, not only from the surface contaminant layers, but also from the bulk

302 material, providing overall information on impurities and on potential qualification as a

303 reference sample system.

304

305 *Ambient Mass spectrometry – PADI, DESI and LESA*

306 The model SDS systems were used to assess the ability of different AMS modalities, PADI,

307 DESI and LESA, for the detection of SDS from different bulk substrate surfaces. AMS

308 addresses the need for rapid analysis with minimal sample preparation. It is known that AMS

309 can potentially provide semi-quantitative information required for assessing the average

310 molecular mass distribution of polymers [32]. Furthermore, molecule ion spectra deliver a

311 characteristic fingerprint-like pattern through which distinct identification of the polymer's

312 composition and polymerization state is possible. The latter measurand allows acquisition of

313 information related to the amount of polymeric impurity residues emerging during industrial

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3 314 manufacturing [33]. Additionally, examples of in-line use of AMS can be found in, crop
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5 315 science, biomedical and surgical scenarios [34,35], thus evidencing their potential utility in
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7 316 automated manufacturing settings. In the following, diverse AMS sampling techniques were
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9 317 applied and compared with respect to their signal outputs related to SDS contaminant
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11 318 detection. Plasma ionization MS has previously been demonstrated to successfully ionize a
12
13 319 variety of molecular classes in the context of PADI MS [36] as well as when serving as a post
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15 320 ionization mechanism in laser desorption MS [37]. However, it is also understood that despite
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17 321 encouraging reports in assisting ionization plasma devices can perform poorly as desorption
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19 322 devices, particularly where the analyte of interest is non-volatile or present on the surface in a
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21 323 physical form not conducive to PADI analysis [38]. Consequently, it was determined in
22
23 324 preliminary studies (data not shown) that PADI was not a suitable desorption ionization
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25 325 technique for analysis of SDS samples of the form studied here and those likely to be
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27 326 encountered medical device contamination studies. DESI and LESA MS were able to
28
29 327 successfully detect the molecular SDS ion from 50 nm thick films, either on Si, SST and
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31 328 HDPE substrates.

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35 329 **Fig.2**

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37 330 SDS was primarily detected in negative ion mode with the loss of the sodium cation [M-Na]-
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39 331 ($C_{12}H_{25}O_4S$) at m/z 265.147 (singly charged mon-isotopic mass with sodium loss). Example
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41 332 mass spectra are shown in Figure 2a and b for DESI and LESA respectively. The peak signal
42
43 333 intensities of the molecular ions vary according to the substrate and solvent used in DESI,
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45 334 probably due to the differences in wettability and conductivity of the different substrate
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47 335 surfaces (see Table S-2, ESM for details). This needs to be taken into consideration when
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49 336 comparing data qualitatively from different samples. LESA analysis also demonstrated
50
51 337 successful detection of the 50 nm SDS films on PE, Si and SST substrates in the negative ion
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338 mode, although any substrate related effects were unclear. It is shown that LESA also
339 successfully detects the molecular anion as with DESI.

340 In summary, the variation of intensity observed for SDS contamination is closely related to
341 the difference in the AMS-based sampling technique that was implemented here, either by
342 using DESI and LESA. These preliminary results therefore demonstrate the potential utility of
343 both LESA and DESI mass spectrometry for use in-line with manufacturing processes.
344 Testing on real world sample forms is a critical next step and will be addressed below.

346 *FTIR and Raman micro-spectroscopic analyses*

347 Vibrational spectroscopy was conducted by exploiting the mutually complementary character
348 of both FTIR and Raman fingerprinting techniques in order to assess a full picture of the SDS
349 molecular composition on the different types of substrates. In Fig. 3a-b FTIR and Raman
350 spectra recorded on the different model systems, i.e. SDS on Si, SST and HDPE, together
351 with the reference fingerprint of the SDS obtained from the pure powder, are shown.

352 **Fig.3**

353 The main vibrational features of the SDS molecule are visible in the stretching region of the
354 CH_x groups at $3000\text{-}2800\text{ cm}^{-1}$ attributed to the symmetric and anti-symmetric CH_2/CH_3
355 stretching modes, in the region between 1500 cm^{-1} and 1050 cm^{-1} which contains the C-C
356 skeletal vibrational modes (between 1050 cm^{-1} and 1150 cm^{-1}) and the CH_2 bending modes
357 ($1440\text{-}1460\text{ cm}^{-1}$), and in the alkyl sulfonate region attributed to the SO_4/SO_3 groups that
358 occurs between $1300\text{-}1000\text{ cm}^{-1}$ and $1000\text{-}400\text{ cm}^{-1}$ for FTIR and Raman, respectively. The
359 tentative IR and Raman assignments attributed to the SDS thin film can be found in more
360 detail in Table S-3 (ESM). Interestingly, as the comparison of the relative ratios of the SDS
361 modes in the FTIR and Raman spectra show, the symmetric bonds, such as the CH_x and C-C

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3 362 skeletal vibrational modes, are stronger in the Raman spectra, while the asymmetric and polar
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5 363 bonds, such as the ones related to the SO_4 , are more dominant in the FTIR spectra (Fig.3a-b).
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7 364 This behavior is consistent with the nature of the molecular transitions that take place in these
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9 365 two techniques, highlighting the importance of a complementary characterization to provide
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11 366 useful information on the analyzed substrate and on the efficient detection of the SDS.

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13 367 FTIR experiments in ATR configuration turned out to be very suitable for the sensitive
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15 368 detection of SDS thin layer coatings on all SDS-coated substrates in the 50 nm regime,
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17 369 likewise by taking advantage of the polarized synchrotron radiation that was guided through
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19 370 the ATR crystal sample interface to enable an effective enhancement of the SDS signal. No
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21 371 assignable overlaps can be found with the sample substrate spectra, apart from the HDPE
22
23 372 sample substrate, the SDS samples were ratioed against their corresponding backgrounds (Si
24
25 373 and SST). For the SDS on HDPE we took a low-emissivity reflective substrate (Kevley
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27 374 Technologies Inc.), as it provides featureless detection in this spectral region of interest and
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29 375 enables an adequate instrumental function and atmospheric background correction.
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31 376 Consequently, we can also observe spectral contributions from HDPE [39], but they do not
32
33 377 strongly interfere (except for the CH_2 deformation mode at $\sim 1470 \text{ cm}^{-1}$ and CH_2 stretching
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35 378 vibration at $\sim 2915 \text{ cm}^{-1}$) with the SDS modes (Fig. 3a). Interestingly, the powder spectrum
36
37 379 slightly differs from the SDS thin film spectra at the spectral region around 1686 cm^{-1} , which
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39 380 can be attributed to C-O stretching vibrations.

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41 381 It has to be noted here that no-contact imaging by using cassegrain objectives was not
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43 382 sensitive enough and contact microspectroscopic imaging by ATR would have the tendency to
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45 383 spread or remove the SDS thin films from the respective substrate surfaces. This is why we
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47 384 lay the focus here on μ -Raman imaging (so-called ' μ -Raman mapping') of SDS model
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49 385 contaminant films.
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3 386 Typical Raman bands of the SDS can be easily observed in the spectra collected on Si and
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5 387 SST substrates, which are mainly characterized by the vibrational bands of the C-C skeleton
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7 388 at 1130 cm^{-1} , 1083 cm^{-1} and 1063 cm^{-1} , by the CH_2 twisting mode at 1296 cm^{-1} , by the
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9 389 bending vibrations of CH_2 groups around 1460 cm^{-1} and by the asymmetric and symmetric
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11 390 stretching vibrations of CH_x groups in the range $2800\text{-}3100\text{ cm}^{-1}$. Specific vibrational signals
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13 391 of the SO_3 group can be mainly found in the Raman spectrum at 632 cm^{-1} , 597 cm^{-1} , 420 cm^{-1}
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15 392 together with a peak at 1083 cm^{-1} attributed to the $\nu_{\text{S}}\text{SO}_4$ that partially overlaps the above-
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17 393 mentioned C-C vibration. No specific signals related to the SST were found in the Raman
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19 394 spectrum of the bare substrate (data not shown), while typical Raman bands of Si were found
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21 395 in the region between $500\text{-}1500\text{ cm}^{-1}$ of the spectrum where the 1st, 2nd and 3rd order at 520
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23 396 cm^{-1} , 1000 cm^{-1} and 1450 cm^{-1} are shown, respectively. Absent or no-interfering overlapping
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25 397 of the Raman signals was observed on these two substrates, allowing an easy identification of
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27 398 the SDS fingerprint on the analyzed surfaces. Micro-Raman mapping was also exploited on
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29 399 these samples to analyze the distribution of the SDS on the surface at sub-micrometric scale.
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31 400 As the chemical images in Fig. 4a-b show, the SDS is not evenly distributed on the surface
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33 401 but small round-shaped convex protrusions of SDS aggregates occur on these substrates. This
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35 402 is due to the amphoteric nature of the SDS molecule which is arranged into micellar structures
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37 403 in polar solutions, by turning its polar headgroups towards the hydrophilic methanol, and its
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39 404 lipophilic tails inwardly towards the center of each micelle. When sprayed onto the different
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41 405 substrates, the micellar structures are maintained more or less in their original shapes.
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406 Fig.4

407 The same analysis was also performed on the HDPE substrate. However, the detection of the
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49 408 SDS on the HDPE was not as straightforward as we observed in the previous cases. As the
50
51 409 SDS on HDPE spectra of Fig.4c show, HDPE has very intense vibrational modes which tend
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3 410 to overlap most of the SDS signals in the Raman spectrum. Raman signals of the HDPE are
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5 411 mainly present in the spectral region between 3000-2800 cm^{-1} and 1500-1300 cm^{-1} where the
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7 412 typical stretching and bending vibrations of the CH_x groups occur, respectively. The CH_2
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9 413 wagging at 1297 cm^{-1} and the C-C stretching vibrations at 1131 and 1064 cm^{-1} are also
10
11 414 shown. Two other small bands are present at 1370 and 1083 cm^{-1} which are assigned to the
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13 415 CH_3 wagging and to the C-C stretching, respectively, indicating the presence of an
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15 416 amorphous phase of the HDPE, while the bands at 1463 cm^{-1} , 1441 cm^{-1} , 1418 cm^{-1} and 1170
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17 417 cm^{-1} are ascribed to the crystalline phase. These signals are clearly visible in all spectra in
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19 418 Fig.4c. In order to reveal the SDS on this substrate, a reference Raman spectrum of the bare
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21 419 HDPE (Fig.4c) was manually subtracted to the ones collected on different locations on the
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23 420 substrates, indicated as points from 1 to 4 in the optical image of Fig. 4d. In particular, as Fig.
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25 421 4e shows, the presence of the SDS on the surface can be specifically revealed by the
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27 422 appearance of the overlapping modes of the C-C and SO_4 at 1083 cm^{-1} after the subtraction.
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29 423 Moreover, another typical mode of the SO_3 is also present at 597 cm^{-1} (data not shown), albeit
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31 424 weaker than the one at 1083 cm^{-1} . Therefore, micro-Raman characterization was demonstrated
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33 425 to be a valid tool for a non invasive and surface sensitive detection of SDS on all three
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35 426 different types of substrates used here, whilst also retaining information about the spatial
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37 427 distribution of the contaminant on the surface.
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44 429 ***SDS contaminated real biomedical devices – Analyses on Hip Liners applying Ambient and***
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46 430 ***Vacuum-based techniques***

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48 431 In the previous section we focused on the multi-technique characterization of SDS model
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50 432 contaminants with respect to chemical composition, identification and distribution across the
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52 433 different types of substrates by using elemental- and molecular-specific methods. However, in
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3 434 industrial manufacturing, biomedical devices such as hip liners, for instance, do not possess
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5 435 any ideally flat or simple geometry, and impurities and contaminants may preferably settle
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7 436 down / stick to relatively inaccessible regions, with potential impact on quality control. The
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9 437 analytical tools discussed below that are commonly used for characterization of flat sample
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11 438 systems will be applied to a SDS-contaminated and non-contaminated polyethylene-based hip
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13 439 liner having a convex geometrical setting. SDS deposition was performed on the convex
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15 440 surface, i.e. outer part of the hip liner, using a concentration value of 0.25 mg/mL because it is
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17 441 close to the CMC of SDS. In reality, such a dosing level is likely to be well below an
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19 442 inhibitory concentration if present on an implant, owing to the large dilution factor
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21 443 encountered when the implant is placed in contact with body fluids during and after surgical
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23 444 implantation (many millilitres). In-vitro cultured cells may also be more susceptible to
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25 445 inhibition when chemically challenged, but 0.25 mg/mL was used because it provides a
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27 446 sufficiently challenging test concentration with regards to testing analytical detection
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29 447 capabilities.
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35 449 *Ambient mass spectrometry – analysis of hip liner*

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37 450 Having carried out preliminary testing of three AMS modalities the analysis of real world
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39 451 samples by DESI and LESA is required. A hip-liner of the kind used in modern hip
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41 452 replacement surgery was used for this purpose. A hip liner is employed to receive the ball of
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43 453 the femoral head, providing a lower friction surface for rotation of the joint as it sits within
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45 454 this new acetabular component within the recipients hip socket. The investigated hip liner was
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47 455 constructed from ultra-high-molecular-weight polyethylene (UHMWPE). The structure of
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49 456 UHMWPE is $(C_2H_4)_n$ with n greater than 100,000 and as such only the lower m/z multimer
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51 457 fragments of this polymer will have the potential to be detected in these experiments, in
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3 458 addition to low mass contaminant compounds on its surface. The instrument configuration for
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5 459 sampling and transfer to the mass analyser differs for DESI and LESA [40–42].
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7 460 Consequently, LESA, with its decoupled sampling and ionization steps and the differing
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9 461 requirements of sample surface position relative to the sampling probe and MS inlet, is
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11 462 potentially more amenable to analysis of more topographically challenging objects.

13 463 **Fig.5**

14
15 464 As a result, LESA MS was able to be carried out on both the convex and concave surfaces of
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17 465 the hip liner, whereas DESI MS was not able to sample successfully from the concave surface.
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19 466 Additionally, data obtained from the convex surface by DESI MS exhibited similar ion
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21 467 intensity but considerably larger variance than that from LESA MS (Fig. S-1 ESM).
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23 468 Negative ion mode LESA spectra recorded from an untreated and SDS coated hip liner
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25 469 surface are shown in Figure 5a and b respectively. From the untreated hip liner surface, ions
26
27 470 are detected in the range of m/z 519-602 with a mass difference of ± 56.06 Da indicating the
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29 471 presence of $(C_4H_8)^-$ groups characteristic of PE. After coating with an approximately 50 nm
30
31 472 thick SDS film, the molecular anion $[M-Na]^-$ at m/z 265.14 was detected by LESA (Figure
32
33 473 5b), similar to that seen from SDS on flat PE (Figure 2). LESA was able to sample from the
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35 474 angled surface both on the inside (concave) and outside (convex) of the hip liner surface,
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37 475 Figure 5d-e respectively. In addition, during LESA analysis, MS/MS collision induced
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39 476 dissociation (CID) data were acquired from the peak at m/z 265.14, helping confirm the
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41 477 structural identity of the ion from its fragmentation pattern (Figure 5c).

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45 46 47 479 *FTIR and Raman micro-spectroscopical analyses*

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49 480 Both spectroscopic techniques were used for the SDS contaminant probing on a hip liner
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51 481 sample. Determination of whether ATR and contactless Raman analysis combined with a

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3 482 microscopical setup serve as appropriate tools for chemical identification of nm layered SDS
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5 483 surface contaminant film spread over the convex side of a hip liner was investigated. The μ -
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7 484 Raman imaging permits spectra to be obtained from very small sample regions of interest,
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9 485 down to less than 1 μm laterally, and, likewise for FTIR, a few microns in depth in general.
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11 486 However, it has to be pointed out that Raman is a scattering technique which is more sensitive
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13 487 to sampling and optical design parameters, consequently small variations may lead to large
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15 488 effects on signal response and signal-to-noise ratios [43], especially in the case of non-ideally
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17 489 flat sample surfaces.

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20 490 **Fig.6**

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22 491 The ATR analysis on the convex hip liners shows that spectral contributions originating from
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24 492 SDS contamination (Table S-3) could be successfully detected on their surface (Fig. 6a).
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26 493 However, it has to be noted here that the CH stretching modes from the SDS do overlap with
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28 494 the HDPE modes in the 3100 - 2700 cm^{-1} spectral region. Clear spectral differences can be
29
30 495 observed in the 1400 – 900 cm^{-1} spectral window that comprises mainly stretching modes
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32 496 from the SO_4 moieties of the SDS.
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34 497 Micro-Raman point mapping was also performed on several locations on the external convex
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36 498 surface of the device demonstrating its applicability even on substrates with a complex
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38 499 geometry. An uncoated hip liner was measured as blank sample. As Fig.6b shows, Raman
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40 500 characterization of the outer hip liner surface suffers from the strong polyethylene background
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42 501 that overlaps with most of the SDS signals in the CH_x stretching and bending regions at 3000
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44 502 - 2800 cm^{-1} and 1500 – 1000 cm^{-1} , respectively. However, specific signals of the SDS can be
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46 503 observed at 632 cm^{-1} , 597 cm^{-1} and 420 cm^{-1} attributed to the vibrations of the SO_3 moieties
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48 504 and in the peak at 1083 cm^{-1} which is interpreted as an overlapping of the SO_4 and C-C
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50 505 skeletal vibration of the molecule.
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3 506 The SDS contaminant signal is neither hindered nor altered, albeit slight signal intensity
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5 507 variations could be detected for both vibrational spectroscopic techniques, hence, a distinct
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7 508 identification on samples having a complex geometry is feasible by using both
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9 509 complementary Raman and IR spectroscopies.
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13 511 *XRF for absolute SDS quantification on Hip Liners*
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15 512 In addition to the flat model systems, real medical devices were analyzed. A hip liner with a
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17 513 non-flat shape represents a challenging measurement geometry for GIXRF due to the curved
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19 514 surface. In particular for the grazing incidence regime the angle of incidence is difficult to
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21 515 determine and consequently also the solid angle of detection. To prevent this, a calibrated
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23 516 aperture is used to provide a well-defined solid angle of detection.
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26 517 The hip liners were analyzed using a photon energy of about 1487 eV to excite all the relevant
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28 518 elements excluding sulfur. The incidence angle is here of about 10° . For the analysis of the
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30 519 hip liners blanks were available and were analyzed as well. The measurements showed small
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32 520 Na contaminations which are significantly smaller, approximately one order of magnitude of
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34 521 the fraction of SDS. Here, a subtraction of the Na background is possible and was carried out.
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37 522 The GIXRF spectra exhibit further contaminations of small amounts of N, Fe, and Mg. These
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39 523 contaminants are also observable on the coated hip liners.
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41 524 In Table 2, the experimentally determined mass deposition of O and Na is shown for the
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43 525 uncoated and coated samples. On basis of the Na content and the knowledge of the
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45 526 stoichiometry, the mass deposition of C, H, S, and O has been determined. Hence, the
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47 527 thickness of the SDS layer is calculated assuming the bulk density of SDS. The SDS
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49 528 contaminated hip liners were analyzed at two different positions, the center and two
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51 529 millimeters away from the center. The thickness at the center position is about 50 nm, which
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3 530 is the same as the target value of the spray coating. But the value of the off-center
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5 531 measurement is considerable smaller, less than 40% of the expected value.
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7 532 **Table 2**

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9 533 The analysis of contaminants on curved surfaces is feasible but with an increased
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11 534 experimental effort in particular in grazing incidence geometry, which is necessary for the
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13 535 quantitative characterization of small amounts of contaminants. This elaborative reference-
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15 536 free approach is paid off as it lays the foundation for the traceable determination of certain
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17 537 contaminations regarding elemental composition and content, in view of developing new
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19 538 reference materials for organic compounds that are scarcely available.
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24 540 **Conclusions**

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26 541 In this systematic inter-comparative approach, we showed and discussed the characterization
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28 542 of deliberately deposited SDS films mimicking contaminations on inorganic and organic
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30 543 substrates, potentially used as reference materials for ambient techniques, i.e. Ambient mass
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32 544 spectrometries, Raman and Infrared spectroscopy, to reliably determine amounts of
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34 545 contamination.
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37 546 Our results demonstrated that the complementary information provided by non-invasive
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39 547 vibrational spectroscopies can be gathered qualitatively, thus increasing reliability in
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41 548 identification of even thin film contaminant layers by their unique Raman and IR spectral
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43 549 fingerprints in the presence of diverse bulk substrate settings. IR and Raman readout tools
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45 550 evidenced the existence of contaminants, even on an emulated SDS-contaminated real
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47 551 biomedical device, i.e. a hip liner with a convex / concave sample geometry. Both techniques
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49 552 may help for reliably and quickly identifying surface impurities during or after industrial
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51 553 processing and can be combined with chemical imaging to reliably localize the SDS
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3 554 contamination on the μm scale. Both readout techniques may be slotted in ahead of the other
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5 555 remaining techniques discussed in our approach, followed by the traceable reference-free
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7 556 XRF analysis. This technique allowed quantification of the Na content originating from the
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9 557 SDS, both on model SDS contaminant layer systems and on the convex side of a hip liner.
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11 558 Specifically, the mass deposition of C, Na, and O was absolutely determined, leading to a
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13 559 dtermined layer thickness of 50 nm on the hip liner, thus, being in line with the intended
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15 560 applied SDS contamination to the real biomedical device.

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17 561 As with Raman and FTIR spectroscopies, AMS provided fingerprint outputs for a fast
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19 562 qualitative identification of surface contaminations. AMS should be used at the end of the
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21 563 traceability chain since it is a moderately destructive technique relying on the removal of
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23 564 material from the sample surface to provide measurements. However, these techniques may
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25 565 even be able to elucidate the state of polymerization, and consequently the resulting extent of
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27 566 polymeric surface cleanliness. For the complex hip liner geometry and large sample size
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29 567 LESA enabled more flexibility in sampling, and gave better signal repeatability for the
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31 568 detection of SDS. Further work towards quantitative measurements from real world samples
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33 569 would significantly benefit the utility of these AMS data for industrial applications.

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37 570 The increase of information depth provided by combining all techniques has the potential to
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39 571 enable even on-line characterization and chemical speciation within the process chain in the
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41 572 biomedical device industry.

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580 interpretation.

581

582 **Compliance with ethical standards**

583 *Conflict of Interest:* The authors declare that they have no conflict of interest.

584 *Research involving Human Participants and/or Animals:* not applicable.

585 *Informed consent:* not applicable.

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737 **Figure Legends**738 **Fig. 1** - XRF spectra of the SDS model contaminant films prepared on different substrates.

739 Spectra were recorded at 1622 eV.

740 **Fig. 2** Negative ion mode was applied for acquisition of (a) DESI mass spectra and (b) LESA

741 mass spectra of a 50 nm thick SDS film on HDPE substrate, measured in the mass range from

742 200 m/z – 500 m/z. The dashed line indicates the SDS molecule anion.

743 **Fig. 3** (a) FTIR spectra of SDS layers on Si, SST and HDPE and (b) corresponding Raman

744 data. The FTIR and Raman spectra of pure SDS are displayed here as reference in the upper

745 part of the graph (a) and (b), respectively.

746 **Fig. 4** Micro Raman images of SDS layers on Si (a) and SST (b). Raman spectra of SDS

747 layers on HDPE at different locations on the substrate (c). The correspondent locations are

748 shown in the optical image in figure (d). Normal and Raman difference spectra (after the

749 subtraction of the HDPE reference) correspond to the locations indicated by the points from 1

750 to 4 in the spectral region between 1150-1070 cm^{-1} (e).751 **Fig. 5** - Negative ion mode LESA mass spectra of a polyethylene hip liner for (a) an untreated

752 surface with the PE peaks marked with circles, (b) the SDS coated surface with the anion of

753 SDS, m/z 265.147 marked with a star for the mass range m/z 100 to 800, and (c) the MS/MS

754 of the m/z 265.147 peak showing the fragmentation of the sulphate and the hydrocarbon.

755 Image of LESA sampling of the concave inner surface of a hip liner (d) and the convex, outer

756 surface of a hip liner (e).

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3 757 **Fig. 6** FTIR (a) and Raman (b) spectral averages calculated from nine different locations
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5 758 single spectra onto the hip liner surface (poly-ethylene) without any SDS coating (top) and of
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7 759 the SDS-coated hip-liner (bottom), respectively.
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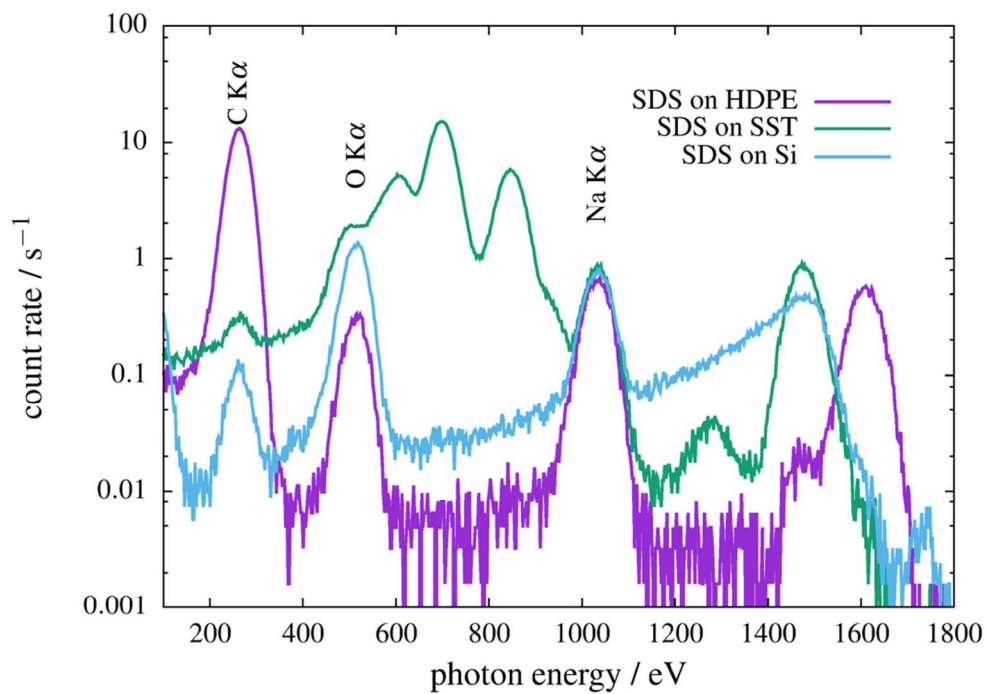


Fig. 1 - XRF spectra of the SDS model contaminant films prepared on different substrates. Spectra were recorded at 1622 eV.

125x86mm (220 x 220 DPI)

Table 1 Measurements at 1622 eV for the quantification of Na, C, and O.

Sample	Mass deposition* / $\times 10^{-7}$ g/cm ²			Uncertainties 15% (k=1)		
	Carbon	Oxygen	Sodium			
SDS on SST	13 ± 2	25 ± 4	3.5 ± 0.5			
SDS on HDPE	n.a.	9.2 ± 1.4	3.3 ± 0.5			
SDS on Si	17 ± 3	36 ± 5	2.9 ± 0.4			

Sample	Mass deposition* / $\times 10^{-7}$ g/cm ²					
	Carbon	Oxygen	Sodium	Sulfur	Hydrogen	Thickness / nm
SDS on SST	22	9.8	3.5	4.9	3.8	44 ± 6
SDS on HDPE	20	9.1	3.3	4.6	3.6	41 ± 6
SDS on Si	18	8.2	2.9	4.1	3.2	37 ± 6

*Mass deposition data (calculated arithmetic means) derived from five single measurements, respectively. The second part shows the calculated mass deposition based on the sodium content assuming stoichiometric SDS and its concluded thickness.

161x134mm (150 x 150 DPI)

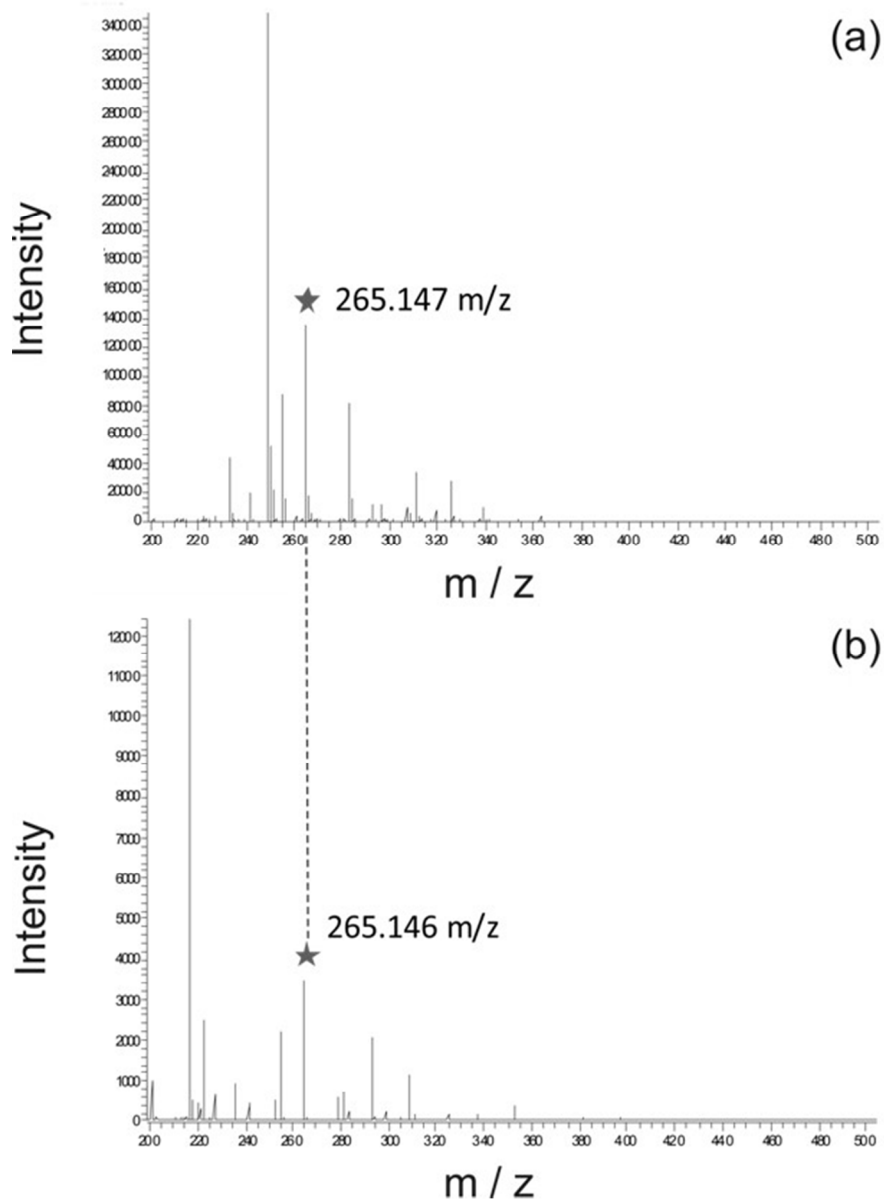


Fig. 2 Negative ion mode was applied for acquisition of (a) DESI mass spectra and (b) LESA mass spectra of a 50 nm thick SDS film on HDPE substrate, measured in the mass range from 200 m/z – 500 m/z . The dashed line indicates the SDS molecule anion.

105x141mm (150 x 150 DPI)

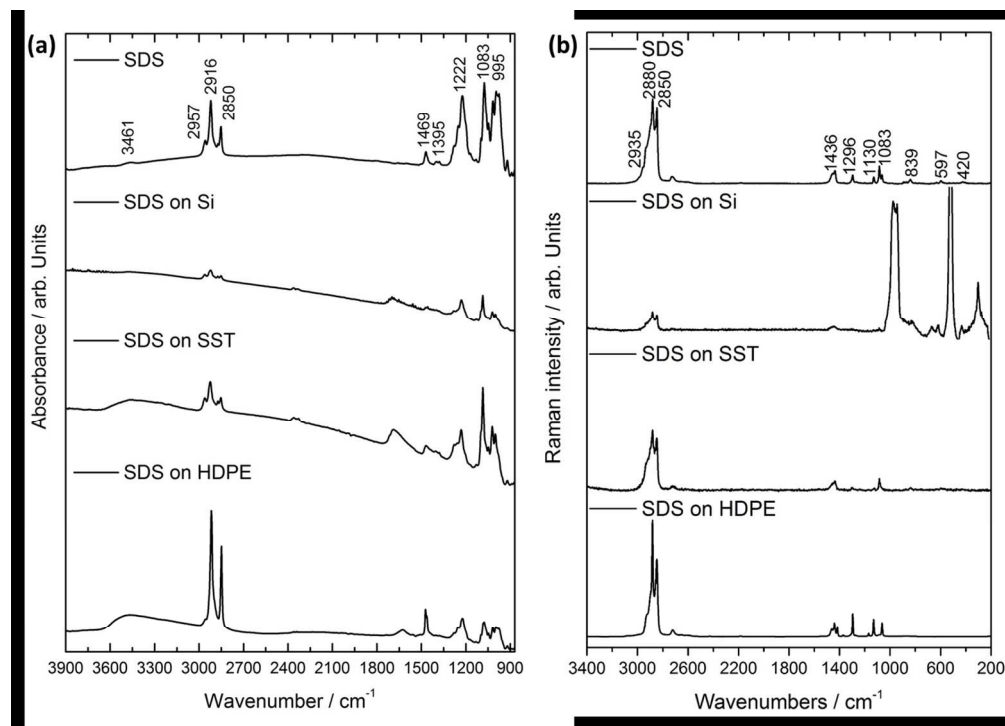


Fig. 3 (a) FTIR spectra of SDS layers on Si, SST and HDPE and (b) corresponding Raman data. The FTIR and Raman spectra of pure SDS are displayed here as reference in the upper part of the graph (a) and (b), respectively.

246x177mm (150 x 150 DPI)

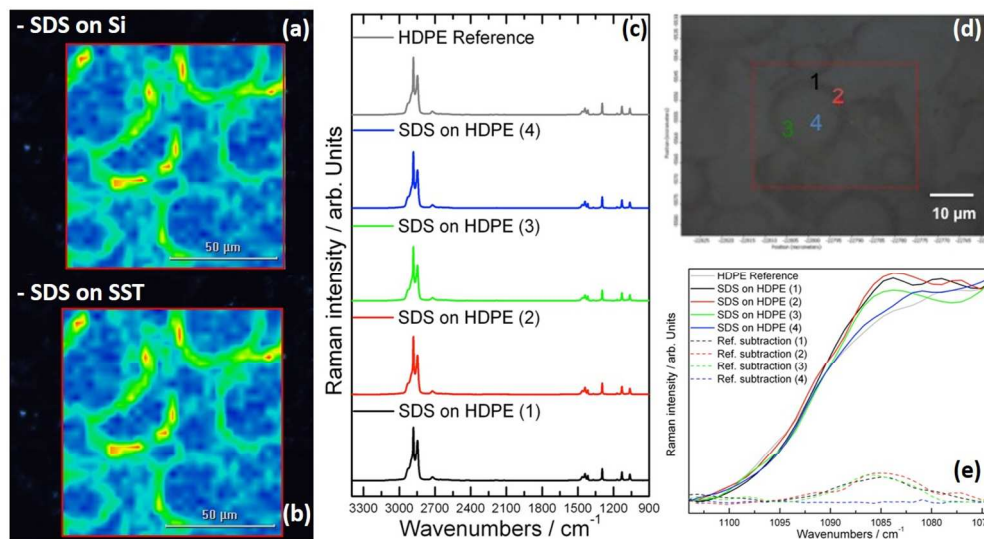


Fig. 4 Micro Raman images of SDS layers on Si (a) and SST (b). Raman spectra of SDS layers on HDPE at different locations on the substrate (c). The correspondent locations are shown in the optical image in figure (d). Normal and Raman difference spectra (after the subtraction of the HDPE reference) correspond to the locations indicated by the points from 1 to 4 in the spectral region between 1150-1070 cm⁻¹ (e).

252x136mm (150 x 150 DPI)

Review

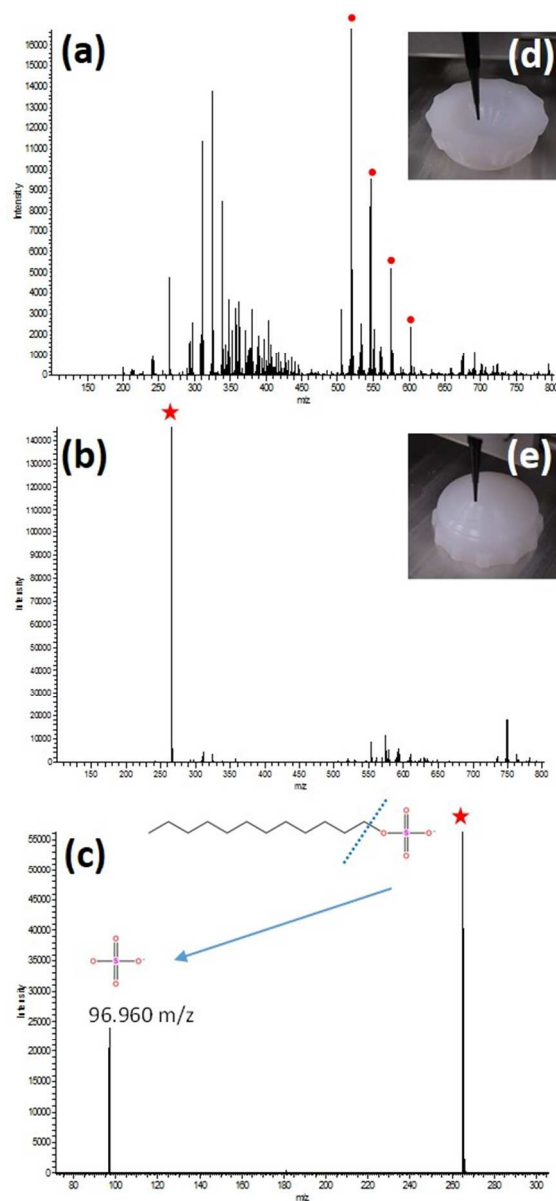


Fig. 5 - Negative ion mode LESA mass spectra of a polyethylene hip liner for (a) an untreated surface with the PE peaks marked with circles, (b) the SDS coated surface with the anion of SDS, m/z 265.147 marked with a star for the mass range m/z 100 to 800, and (c) the MS/MS of the m/z 265.147 peak showing the fragmentation of the sulphate and the hydrocarbon. Image of LESA sampling of the concave inner surface of a hip liner (d) and the convex, outer surface of a hip liner (e).

88x184mm (150 x 150 DPI)

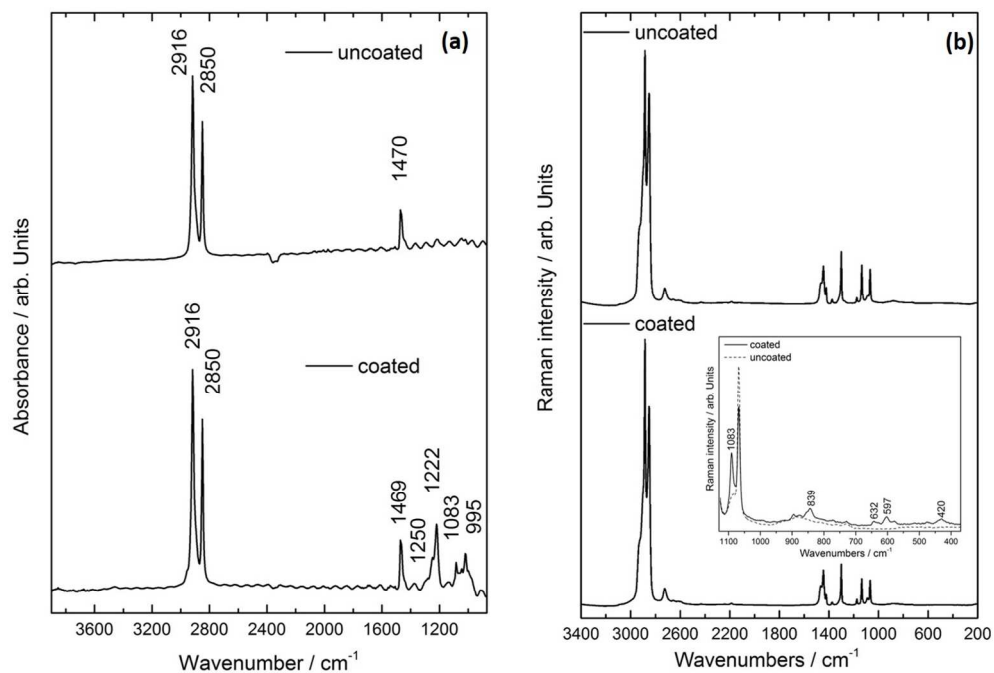


Fig. 6 FTIR (a) and Raman (b) spectral averages calculated from nine different locations single spectra onto the hip liner surface (poly-ethylene) without any SDS coating (top) and of the SDS-coated hip-liner (bottom), respectively.

254x175mm (150 x 150 DPI)

Table 2 Measurements at 1487 eV for the quantification of Na and O.

Mass deposition / $\times 10^{-7}$ g/cm ²	Uncertainties 15% (k=1)						
	Sample	Carbon	Oxygen	Sodium			
Off-center	n.a.	7.38	1.910				
Center	n.a.	13.8	4.530				
'Reference'	n.a.	348	0.510				
Mass deposition / $\times 10^{-7}$ g/cm ²	Sample	Carbon	Oxygen	Sodium	Sulfur	Hydrogen	Thickness / nm
Off-center	8.77	3.90	1.40	1.95	1.52	18	
Center	25.1	11.2	4.02	5.59	4.37	50	

169x106mm (150 x 150 DPI)

Review

Electronic Supplementary Material (ESM)

A methodological inter-comparison study on the detection of surface contaminant sodium dodecyl sulfate applying ambient- and vacuum-based techniques

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Further theoretical details on *Reference-free XRF*

The quantitative analysis of the absolute mass per unit area and the elemental composition is carried out by using a fundamental parameter approach as introduced in Beckhoff et al. [1]. Here, all experimental and atomic fundamental parameters have to be well-known. For this purpose, the calibrated instrumentation is used. The atomic fundamental parameters are taken from databases, e.g. Elam database [2]. Excluding the photoelectric cross section it follows from the Ebel database [3] and the fluorescence yield for the carbon K edge follows from [4] according to the equation:

$$\frac{m_i}{F_I} = \frac{-1}{\mu_{tot,i}} \ln \left\{ 1 - \frac{P_i}{P_{0,Wsurf} \tau_{i,E_0} Q \frac{\Omega_{det}}{4\pi} \frac{1}{\sin \psi_{in}} \frac{1}{\mu_{tot,i}}} \right\}$$

Table S-1 Parameters for the equation given above with their tentative assignments and meanings.

Parameter	Tentative assignments
E_0	photon energy of the incident (excitation) radiation
$P_0 = S_0/\sigma_{Diode,E_0}$	radiant power of the incident radiation
S_0	signal of the photodiode measuring the incident radiation
σ_{Diode,E_0}	spectral responsivity of the photodiode
Ψ_{in}	angle of incidence with respect to the wafer surface
E_i	photon energy of the fluorescence line l of the element i
Ψ_{out}	angle of observation
R_i	detected count rate of the fluorescence line l of the element i
ϵ_{Det,E_i}	detection efficiency of the SDD detector at the photon energy E_i
Ω_{Det}	effective solid angle of detection
$\mu_{i,E}$	absorption cross section of the element i at the photon energy E

$$\mu_{tot,i} = \mu_{i,E_0} / \sin \psi_{in} + \mu_{i,E_i} / \sin \psi_{out}$$

τ_i	photo electric cross section of the element i at the photon energy
G	transition probability of the fluorescence line l belonging to X_i
Ω	fluorescence yield of the absorption edge X_i
Q	$Q = \omega_{X_i} g_{l,X_i}$

Further details on Results & Discussion

Ambient Mass spectrometry – PADI, DESI and LESA

Table S-2 Detection of SDS from HDPE, SS and Si using DESI for 50 nm thick films using both 50:50 MeOH:H₂O and 90:10 ACN:H₂O.

Sample	Ion intensity of molecular anion [C ₁₂ H ₂₅ O ₄ S ⁻ at m/z 265.147] (number of molecular ions × 10 ⁶)	
SDS thickness	50 nm	50 nm
(Solvent used)	(MeOH:H ₂ O)	(ACN:H ₂ O)
SDS on SST	1.86 ± 0.21	0.15 ± 0.03
SDS on HDPE	2.32 ± 0.73	9.56 ± 0.73
SDS on Si	6.62 ± 2.28	0.26 ± 0.08

FTIR and Raman (micro-) spectroscopical analyses

The detection of SDS coating was successful, characteristic and mutually complementary Raman and IR fingerprints could be detected. Modes and their tentative assignments are listed in Table S-3.

Table S-3 Raman and mid-infrared vibrational modes of sodium dodecyl sulfate (SDS).

v: stretching, δ : deformation. as, s: (a)symmetrical. τ : twisting. ρ : rocking

Raman Modes / cm^{-1}	Assignments [5] / cm^{-1}	Infrared Modes/ cm^{-1}	Assignments [6–8]
420	SO ₃	n.a.	n.a.
597	SO ₃	n.a.	n.a.
632	SO ₃	n.a.	n.a.
839	S-OC	n.a.	n.a.
891	ρ CH ₂	n.a.	n.a.
n.a.	n.a.	995	v C-C
n.a.	n.a.	1021	v _s (OSO ₃ ⁻)
1063	v _{asym} C-C trans	n.a.	n.a.
1083	v _s SO ₄ / v C-C gauche	1083	v _s (OSO ₃ ⁻)
1130	v _{sym} C-C trans	n.a.	n.a.
n.a.	n.a.	1222	v _{as} (OSO ₃ ⁻)
n.a.	n.a.	1250	v _{as} (OSO ₃ ⁻)
1295	τ CH ₂	n.a.	n.a.
1435	δ CH ₂	n.a.	n.a.
1455	δ CH ₂	1469	δ CH ₂
2846	v _{sym} CH ₂	2850	v _{sym} CH ₂

2860	$\nu_{\text{sym}} \text{CH}_3$ Fermi res.	n.a.	n.a.
2880	$\nu_{\text{asym}} \text{CH}_2$	2916	$\nu_{\text{as}} \text{CH}_2$
2900	Fermi resonance	n.a.	n.a.
2935	Fermi resonance	n.a.	n.a.
2961	$\nu_{\text{asym}} \text{CH}_3$	2957	$\nu_{\text{as}} \text{CH}_3$

Ambient Mass spectrometry – hip liner

The comparison of LESA and DESI MS on the convex region of the hip liner was carried out on two hip liners where one was deliberately contaminated and one analysed as-received. These analyses were carried out in triplicate and the results are shown in Figure S-1 below.

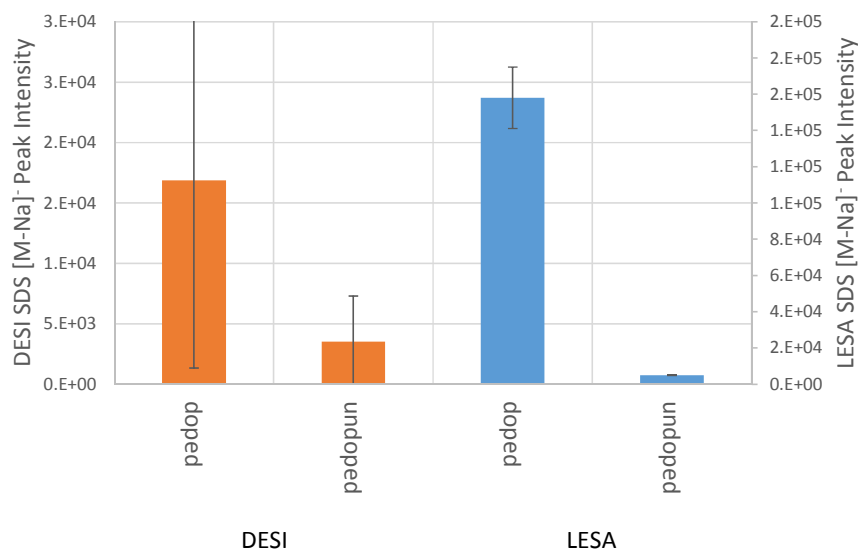


Figure S-1 - Mean signal intensities for SDS $[\text{M-Na}]^-$, m/z 265.147, from the hip liner surface with and without SDS doping for DESI and LESA.

The detection of SDS on the as-received samples was low but non-zero for LESA and with higher but more variable signal via DESI with the consequence that these data are not significantly different statistically. The detected ion intensity for the doped surface hip liner has a similar

relationship with respect to spread of data with LESA being notably less variable than DESI and with an apparent substantial difference in ion intensity that is consequently not statistically significant. Therefore, these data suggest similar results from both DESI and LESA MS analysis of doped and un-doped surfaces and supports the applicability of these techniques for in-line industrial analysis. However, the larger variability and stricter sampling geometry requirements mark LESA MS the more appropriate technique DESI in this particular example.

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